

# UNISONIC TECHNOLOGIES CO., LTD

MCK100 **SCR Preliminary** 

# **SENSITIVE GATE SILICON** CONTROLLED RECTIFIERS REVERSE BLOCKING **THYRISTORS**

#### DESCRIPTION

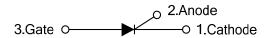
The UTC MCK100 is a sensitive gate silicon controlled rectifiers reverse blocking thyristor. It provides the customers with high surge current capability, high blocking voltage to 600 V and high switching

The UTC MCK100 is suitable for sensing and detection circuits and high volume line - powered consumers applications.

#### **FEATURES**

- \* High Surge Current Capability
- \* High Blocking Voltage to 600 V
- \* On-State Current Rating of 0.8 A RMS @ Tc=80°C
- \* High Switching Speed (20 V/µs Minimum @ T<sub>C</sub>=110°C)
- \* Reliability and Uniformity

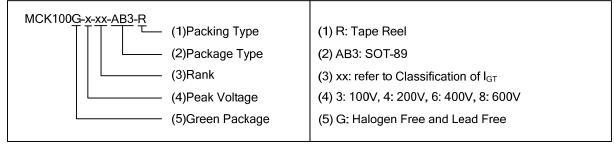
# **SYMBOL**



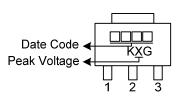
#### **ORDERING INFORMATION**

Ordering Number	Dookogo	Pin assignment			Dealing	
	Package	1	2	3	Packing	
MCK100G-x-xx-AB3-R	SOT-89	K	Α	G	Tape Reel	

Note: Pin assignment: G: Gate A: Anode K: Cathode



# **MARKING**



**SOT-89** 

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# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Deals Decetitive Off Otata Valtage (Nets O)	MCK100-3		100	
Peak Repetitive Off-State Voltage(Note 2) (T <sub>J</sub> =-40 ~ 110°C, Sine Wave, 50 ~ 60Hz, Gate Open)	MCK100-4	$V_{DRM}$	200	V
	MCK100-6	V <sub>RRM</sub>	400	V
	MCK100-8		600	
Peak Gate Voltage – Reverse(T <sub>A</sub> =25°C, Pulse Width≤1.0μs)		$V_{GRM}$	5.0	V
On-Sate RMS Current (T <sub>C</sub> =80°C) 180°C Condition Angles		$I_{T(RMS)}$	0.8	Α
Peak Non-Repetitive Surge Current (1/2 cycle, Sine Wave, 60Hz, T <sub>J</sub> =25°C)		I <sub>TSM</sub>	10	Α
Peak Gate Current-Forward (T <sub>A</sub> =25°C, Pulse Width≤1.0μs)		$I_{GM}$	1.0	Α
Circuit Fusing Considerations (t=8.3 ms)		l <sup>2</sup> t	0.415	A <sup>2</sup> s
Forward Peak Gate Power (T <sub>A</sub> =25°C, Pulse Width ≤1.0µs)		$P_GM$	2	W
Forward Average Gate Power (T <sub>A</sub> =25°C, t=8.3ms)		$P_{G(AV)}$	0.1	W
Operating Junction Temperature @ Rated V <sub>RRM</sub> and V <sub>DRM</sub>		$T_J$	-40 ~ 125	°C
Storage Temperature		$T_{STG}$	-40 ~ 150	°C

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

  Absolute maximum ratings are stress ratings only and functional device operation is not implied
  - 2. V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

#### **■ THERMAL CHARACTERISTICS**

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	$\theta_{JA}$	200	°C/W
Junction to Case	$\theta_{ m JC}$	75	°C/W

#### ■ ELECTRICAL CHARACTERISTICS(T<sub>J</sub>=25°C, unless otherwise specified)

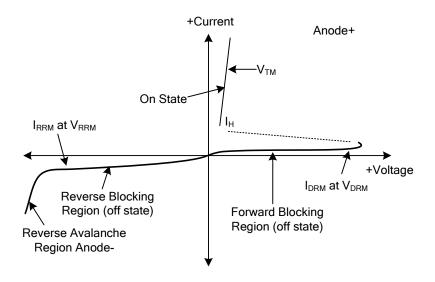
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Peak Repetitive Forward or	T <sub>C</sub> =25°C	$I_{DRM}$ $V_{D}$ =Rated $V_{DRM}$ and $V_{RRM}$ ,				10	
Reverse Blocking Current (Note 1)	T <sub>C</sub> =110°C	$I_{RRM}$	$R_{GK}=1k\Omega$			100	μA
ON CHARACTERISTICS							
Peak Forward On-State Voltage (N	lote 3)	$V_{TM}$	I <sub>TM</sub> =1A Peak @ T <sub>A</sub> =25°C			1.7	V
Gate Trigger Current (Continuous	dc) (Note2)	I <sub>GT</sub>	$V_{AK}$ =7.0V, $R_L$ =100 $\Omega$ , $T_C$ =25 $^{\circ}$ C		40	200	μΑ
Holding Current (Note 2)	T <sub>C</sub> =25°C	- I <sub>H</sub>	V <sub>AK</sub> =7V, initiating		0.5	5.0	m A
Holding Current (Note 3)	T <sub>C</sub> =-40°C		current=20mA			10	mA
Latab Cumant	T <sub>C</sub> =25°C	ΙL	V <sub>AK</sub> =7V, I <sub>G</sub> =200μA		0.6	10	A
Latch Current	T <sub>C</sub> =-40°C					15	mA
Gate Trigger Current	T <sub>C</sub> =25°C	\/	V <sub>AK</sub> =7V, R <sub>L</sub> =100Ω		0.62	0.8	\ /
(continuous dc) (Note 2)	T <sub>C</sub> =-40°C	$V_{GT}$				1.2	V
DYNAMIC CHARACTERISTICS							
			V <sub>D</sub> =Rated V <sub>DRM</sub> , Exponential				
Critical Rate of Rise of Off-State Voltage		dV/dt	Waveform, R <sub>GK</sub> =1000Ω,	20	35		V/µs
			T <sub>J</sub> =110°C				
Critical Rate of Rise of On-State Current		di/dt	I <sub>PK</sub> =20A, P <sub>W</sub> =10μs,			50	Λ/μο
		ui/dt	diG/dt=1A/µs, lgt=20mA			50	A/µs

Notes: 1.  $R_{\text{GK}}\text{=}1000\Omega$  included in measurement.

- 2. Does not include R<sub>GK</sub> in measurement.
- 3. Indicates Pulse Test Width≤1.0ms, duty cycle ≤1%

### ■ VOLTAGE CURRENT CHARACTERISTIC OF SCR

SYMBOL	PARAMETER
$V_{DRM}$	Peak Repetitive Off Stat Forward Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Off State Reverse Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
$V_{TM}$	Peak On State Voltage
I <sub>H</sub>	Holding Current



# ■ CLASSIFICATION OF I<sub>GT</sub>

RANK	В	С	AA	AB	AC	AD
RANGE	48 ~ 105	95 ~ 200	8 ~ 16	14 ~ 21	19 ~ 25	23 ~ 52

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